

Search Notes

Application/Control No.

10/047,177

Examiner

Erin M. File

Applicant(s)/Patent under
Reexamination

LAI, YHEAN-SEN

Art Unit

2634

SEARCHED

| Class | Subclass | Date | Examiner |
|-------|----------|-----------|----------|
| 375 | 229 | 4/10/2005 | EMF |
| 375 | 232 | 4/10/2005 | EMF |
| 375 | 290 | 4/10/2005 | EMF |
| 455 | 296 | 4/10/2005 | EMF |
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INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
|-------|----------|------|----------|
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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

| | DATE | EXMR |
|--|-----------|------|
| EAST US PAT, USPGPUB, EPO, JPO DERWENT, IBM | 4/10/2005 | EMF |
| PALM INVENTORSHIP | 4/10/2005 | EMF |
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